


<b>Search Notes</b>  	<b>Application/Control No.</b>  10565715	<b>Applicant(s)/Patent Under Reexamination</b>  CHAVEZ ET AL.
	<b>Examiner</b>  REBECCA LEE	<b>Art Unit</b>  4181

SEARCHED			
Class	Subclass	Date	Examiner
423	594.160	09/02/08	RL
423	594.160 (updated)	12/23/08	RL
252	192	12/23/08	RL

SEARCH NOTES		
Search Notes	Date	Examiner
inventor name search in East	09/02/08	RL
Term searched in EAST (updated)	12/23/08	RL
Term searched in STN (Updated)	12/23/08	RL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--